



# Analog Comparator



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## 1) Two Stage Open Loop Comparator

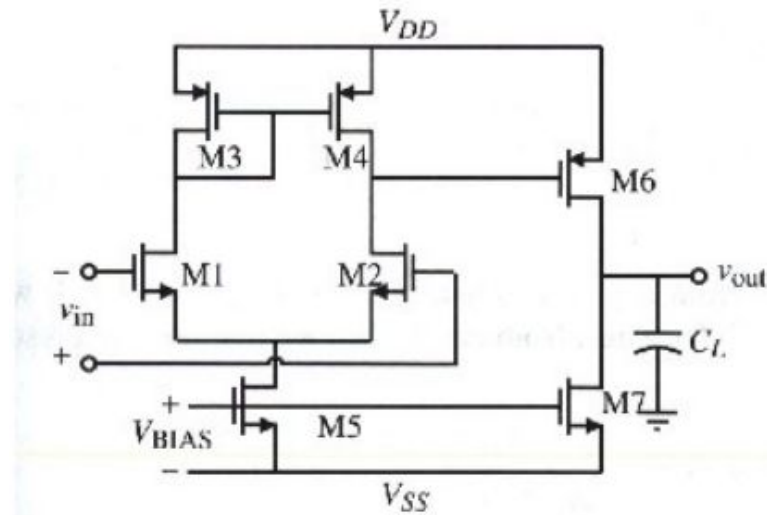


Fig 1 Two stage CMOS Comparator



## Theory

- A comparator requires a differential input and sufficient gain to be able to achieve the desired resolution.
- The two stage opamp used in an open loop mode makes an excellent implementation of the comparator.
- It is preferred not to compensate the comparator so that it has the largest bandwidth possible, which will give a faster response.



## Theory

- The output stage is a current sink inverter.
- The maximum output voltage, assuming that the gate of M6 has a minimum voltage given as  $V_{G6(min)}$ , can be expressed as

$$V_{OH} = V_{DD} - (V_{DD} - V_{G6(min)} - |V_{TP}|)[1 - \sqrt{1 - (2 I_7 / B_6 (V_{DD} - V_{G6(min)} - |V_{TP}|)^2)}]$$

- The minimum output voltage is

$$V_{OL} = V_{SS}$$



## Working

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- Firstly we will be choosing one of the input gates equal to a dc voltage and find output voltage of the first and second stages when the other input gate is above and below the dc voltage on the first gate.
- Let us begin by assuming that  $V_{G1} > V_{G2}$ . MOSFETS M3 and M4 are current mirror therefore  $i_1 = i_3 = i_4$  which is greater than  $i_2$ . Consequently,  $v_{o1}$  increases because of the difference current flowing into  $c_1$ . Hence we obtain  $V_{out}$  as High ie.  $V_{OH}$



## Working

- Next we assume  $V_{G1} < V_{G2}$ . In this case  $i_1 = i_3 = i_4$  which is less than  $i_2$ . Consequently,  $v_{o1}$  decreases because of the difference current flowing into  $c_1$ . Therefore  $V_{out}$  obtained is low.
- The sum of currents in the 2 branches of the first stage is equal to  $I_{ss}$ .
- When  $V_{G1} = V_{G2}$ , current  $I_{ss}$  is equally divided in the 2 branches of first stage.

## 2) Preamplifier Latch based Comparator

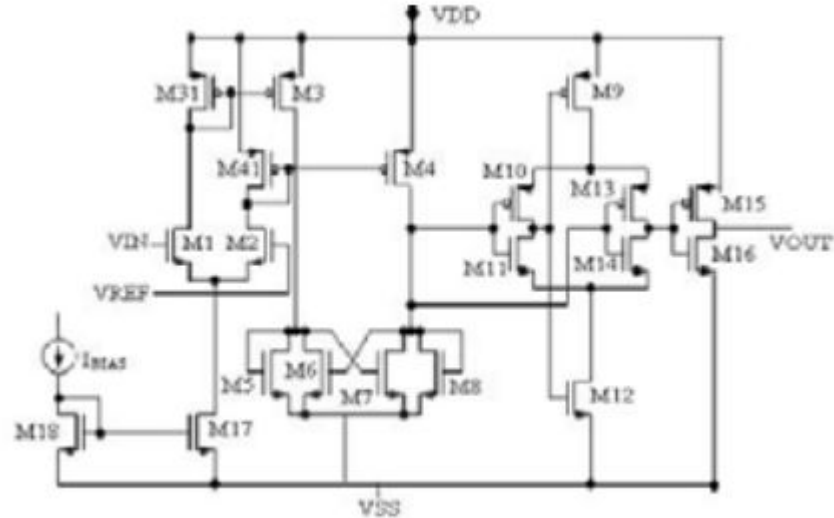


Fig.2 Preamplifier latch based comparator





## Theory

- Preamplifier latch based comparator circuit consists of a preamplifier followed by a latch.
- The major drawback of the latch comparator is the offset error caused by transistor mismatch and unbalanced charge residues .To overcome this a preamplifier circuit is used.
- The basic principle of the preamplifiers is that it amplifies the input signal and feeds it to the input of latch which is designed by using back to back inverter
- High performance comparators are needed to amplify a small input (or the difference between the input voltage and a reference voltage) to a level large enough to be detected by digital logic circuits within a very short time.

## Working

- The comparator consists of three stages: The input preamplifier, A positive feedback or decision stage, and an output buffer. Differential amplifier will act as a preamplifier circuit.
- Preamplifier:

Preamplifier is used to avoid kickback noise. It is implemented using Differential amplifier.

- This circuit is a differential amplifier with active loads. The sizes of M1 and M2 are set by considering the diff-amp transconductance and the input capacitance. The transconductance sets the gain of the stage, while the input capacitance of the comparator is determined by the size of M1 and M2.

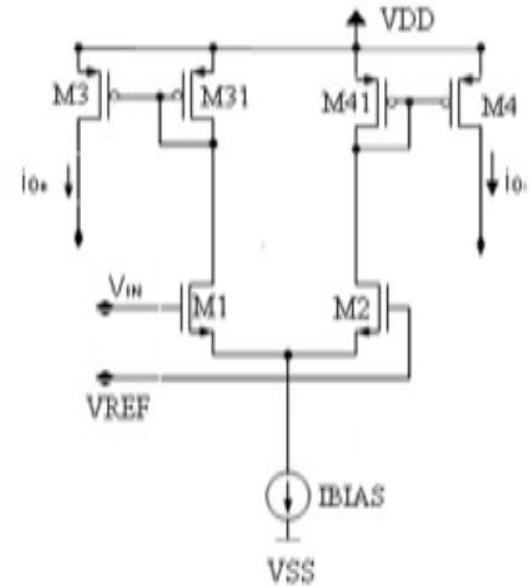


Fig.3 Preamplifier



## LATCH – A decision circuit

- This circuit must be capable of discriminating the mV signals.
- The circuit uses positive feedback from the cross-gate connection transistor to increase the gain of the decision element. If  $iO^-$  increases  $iO^+$  decreases, switching takes place when  $V_{DS7} = V_{THN6}$ . At this point  $M_6$  starts to take current away from  $M_5$ .
- This decreases  $V_{DS5}$  and thus  $M_7$  turns off.
- Assuming that the maximum value of  $vO^-$  or  $vO^+$  equal to  $2V_{THN}$ , then  $M_6$  and  $M_7$  operate in either cutoff or triode regions.  $V_{DS7}$  reaches  $V_{THN}$ , and thus  $M_7$  enters the saturation region

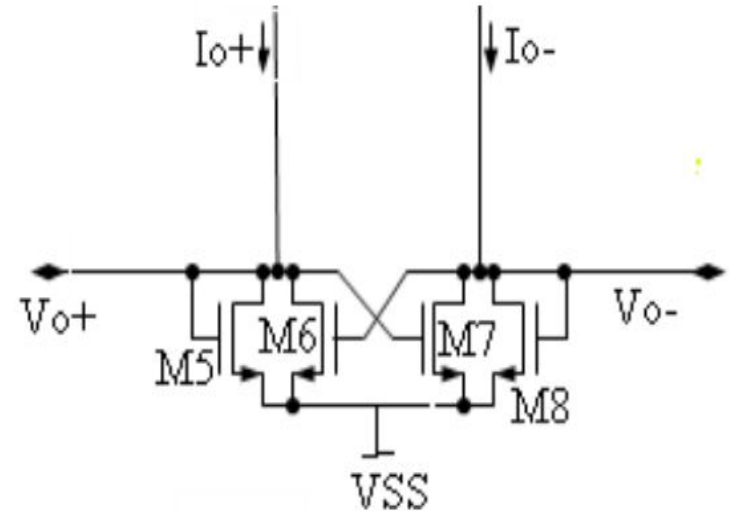


Fig.4 Latch



## Output Buffer

- The main purpose of the output buffer is to convert the output of the decision circuit into a logic signal (i.e. 0 or 5 V).
- The output buffer should accept a differential input signal and not have slew rate limitations.
- A self-biasing differential amplifier is used as the comparator output buffer.

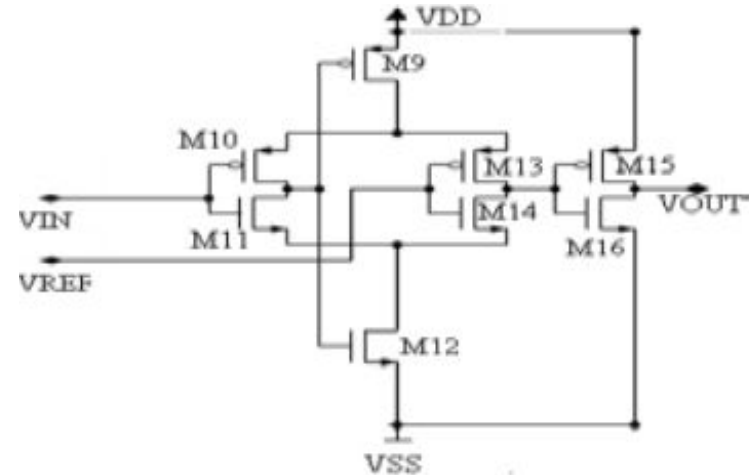


Fig.5 Output Buffer



## Current Mirror

- The current source/sink is a basic building block in CMOS IC design and is used extensively in analog integrated circuit design.
- Ideally, the output impedance of a current source/sink should be infinite and capable of generating or drawing a constant current over a wide range of voltages.
- However, finite values of  $r_o$  and a limited output swing required to keep devices in saturation will ultimately limit the performance of the mirror.

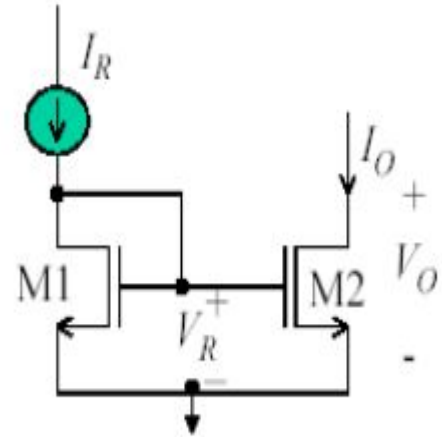


Fig.6 Current Mirror

# Results

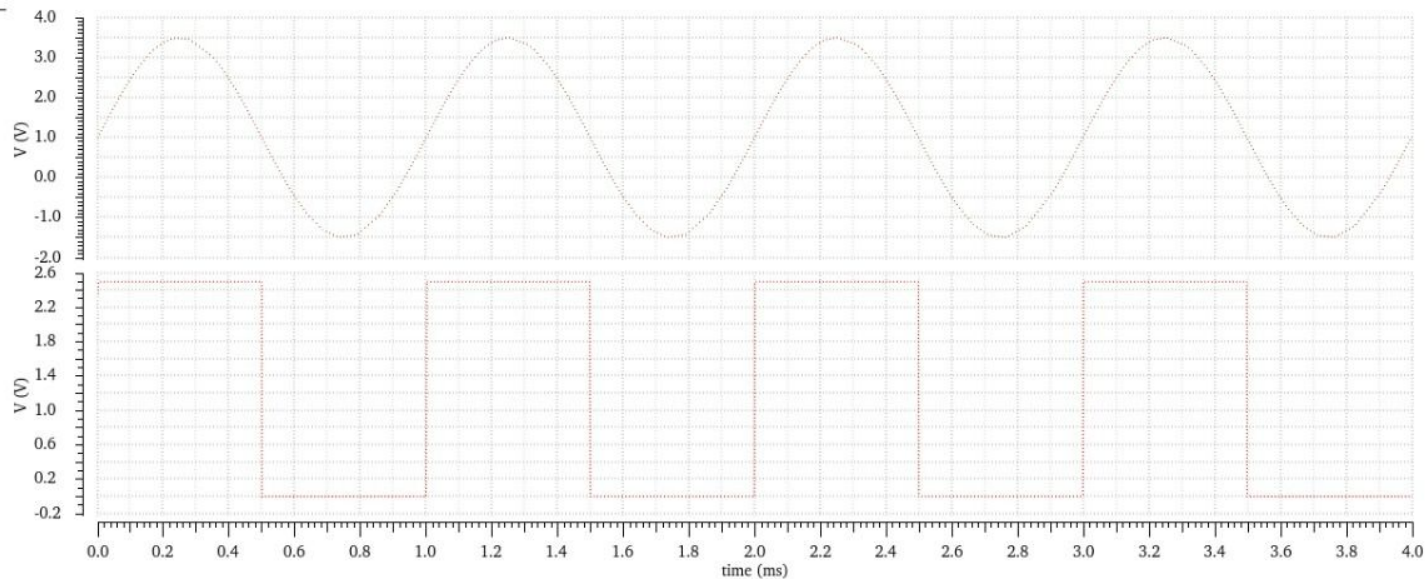
Transient Response

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## Results

- Performs when the input has a difference which is in the range of **5mV to 100V** without any output noise.
- For the least difference of 5mV the **delay time** of the comparator was to be calculated as **89ns**.
- The power dissipated during this process is **888.168uWatt**.



## References

1. Majumder, A., Das, M., Nath, B., Mondal, A. J., & Bhattacharyya, B. K. (2016, April). **“Design of low noise high speed novel dynamic Analog Comparator in 65nm technology”**. In *2016 26th International Conference Radioelektronika (RADIOELEKTRONIKA)* (pp. 115-120). IEEE.
2. A. Khorami, M. B. Dastjerdi and A. F. Ahmadi, **"A low-power high-speed comparator for analog to digital converters,"** *2016 IEEE International Symposium on Circuits and Systems (ISCAS)*, 2016, pp. 2010-2013, doi: 10.1109/ISCAS.2016.7538971.
3. Gireeja Amin**”Design and Simulation of High Speed,Low power Preamplifier Based CMOS Comparator Using 0.13μ technology”**,Indian Journal of Research, April 2012
4. Shabi Tabassum, Anush Bekal, Manish Goswami,**”A Low Power Preamplifier Latch based Comparator Using 180nm CMOS Technology”**, 2013 IEEE Asia Pacific conference on Postgraduate Research in Microelectronics and Electronics